

Geostatistical inference under preferential sampling: Final presentation

By Peter Diggle, Raquel Menezes, and Ting-li Su

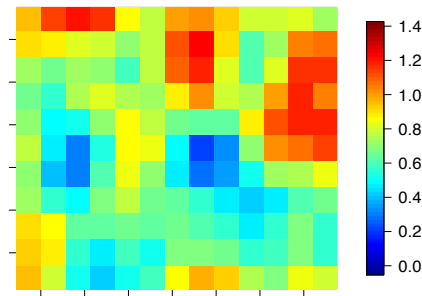
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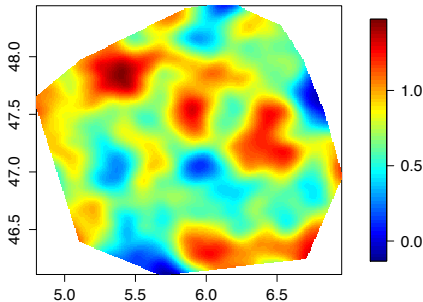
Divisions of Spatial Statistics

- ▶ Cressie (1991) and Gelfand (2010) divide spatial statistics into 3 areas:
 - ▶ discrete data
 - ▶ continuous data
 - ▶ point patterns



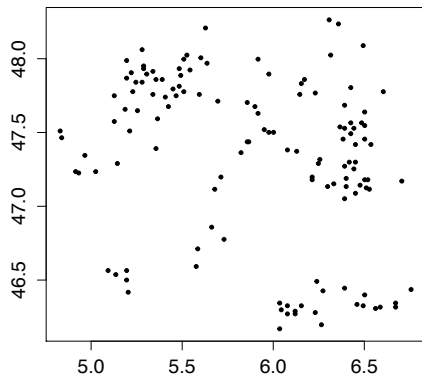
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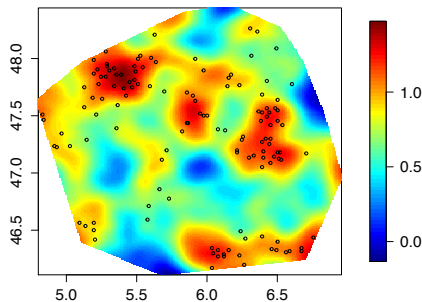
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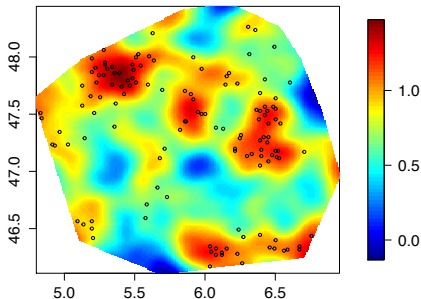
Divisions of Spatial Statistics

- ▶ Cressie (1991) and Gelfand (2010) divide spatial statistics into 3 areas:
 - ▶ discrete data
 - ▶ continuous data
 - ▶ point patterns
- ▶ Diggle et al. (2013) instead gives 2 subdivisions of spatial statistics:
 - ▶ continuous data
 - ▶ discrete data
- ▶ This emphasizes random nature of sampling locations



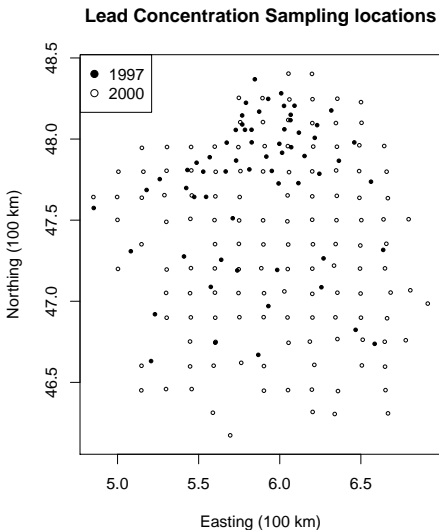
Divisions of Spatial Statistics

- ▶ Classically, data locations are assumed to be fixed constants
- ▶ What happens when the sample locations depend on the measured process itself?
 - ▶ This is called **preferential sampling**



Problems Addressed

- ▶ Determining if data is sampled preferentially
- ▶ How preferential sampling affects 'naive' inference
- ▶ Effective model for preferential sampling
- ▶ Focus on lead levels in Galicia, Spain and simulated experiments



Classical Model

$$Y_i = \mu + S(x_i) + Z_i,$$

Y_i : observation at location x_i

μ : mean

$S(\vec{x}) \sim \text{MVN}(\vec{0}, \Sigma(\vec{x}))$: spatially correlated portion of process

$Z_i \stackrel{iid}{\sim} \mathcal{N}(0, \tau^2)$: measurement noise

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Log likelihood:

$$\mathcal{L}(\vec{\theta}) = -\frac{1}{2} \log(|\Sigma_0|) - \frac{1}{2} (\vec{Y} - \vec{\mu})' \Sigma_0^{-1} (\vec{Y} - \vec{\mu}) - \frac{n}{2} \log(2\pi)$$

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Common assumptions:

- ▶ x_i are sampled independently of true process $\mu + S$
- ▶ Stationarity

Variograms

- ▶ **Stationarity**: under stationarity,
 $\text{Var}(S(x_i) - S(x_j)) = V(x_i - x_j)$
- ▶ **Isotropy**: under isotropy (and stationarity),
 $\text{Var}(S(x_i) - S(x_j)) = V(|x_i - x_j|)$
- ▶ **Variograms** define the spatial structure of the covariance in S
- ▶ Empirical estimate given data Y_i at location x_i (under stationarity and isotropy):

$$\hat{V}(d) = \frac{1}{|N(d)|} \sum_{|x_i - x_j| \in N(d)} (Y_i - Y_j)^2$$

where $N(d)$ is the set of pairs (x_i, x_j) with $|x_i - x_j| \approx d$

- ▶ This estimator assumes non-preferentiality

Variograms

Matérn theoretical variogram:

$$V(d) = \sigma^2(1 - \rho(u \mid \phi, \kappa)) + \tau^2$$

where

$$\rho(u \mid \phi, \kappa) = \frac{1}{2^{\kappa-1}\Gamma(\kappa)}(u/\phi)^{\kappa}K_{\kappa}(u/\phi),$$

is the Matérn correlation function

u : distance

ϕ : scale

κ : smoothness

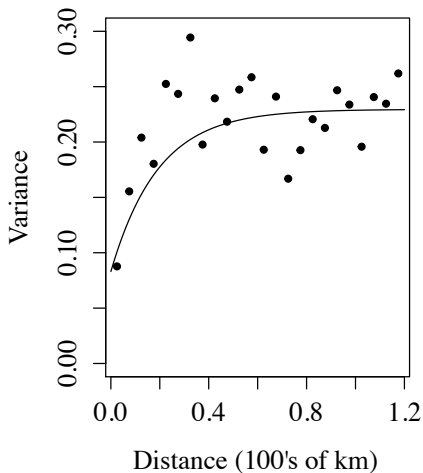
σ^2 : is the variance of S

τ^2 : measurement variance

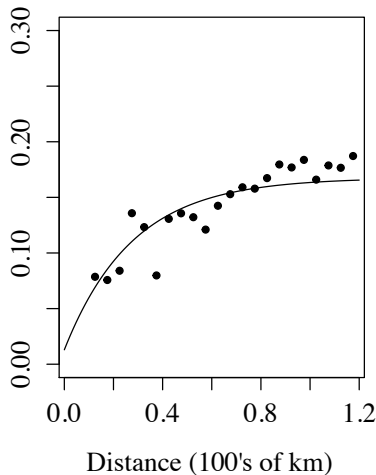
$K_{\kappa}(\cdot)$: Bessel function

Variograms of Log-Lead Data (Classical)

1997 Variogram



2000 Variogram



Model for Preferential Sampling

Three assumptions for model:

1. S is still a stationary, mean zero Gaussian process
(so $S(\vec{x}) \sim \text{MVN}(\vec{0}, \Sigma(\vec{x}))$)
2. Conditional on S , X is an inhomogeneous Poisson process
with random intensity

$$\Lambda(x) = \exp \{ \alpha + \beta S(x) \}$$

3. $Y_i | S, X \stackrel{iid}{\sim} \mathcal{N}(\mu + S(x_i), \tau^2)$

$1 + 2 \Leftrightarrow X$ is a log Gaussian Cox process (LGCP)

Log-Gaussian Cox Processes

A **Cox process** is a stochastic point process that for B, B' bounded Borel sets satisfies:

- ▶ $N(B) \sim \text{Pois} \left(\int_B \Lambda(x) dx \right)$
- ▶ $N(B) \perp\!\!\!\perp N(B')$ when $B \cap B' = \emptyset$

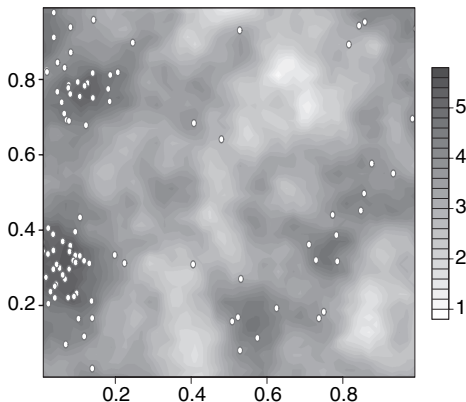


Figure : From Diggle et al. 2010. An example of a LGCP on unit square where $\beta = 2$, $\alpha = 1$, and S has Matérn covariance.

Testing Affect of Sample Designs: Samplings Schemes

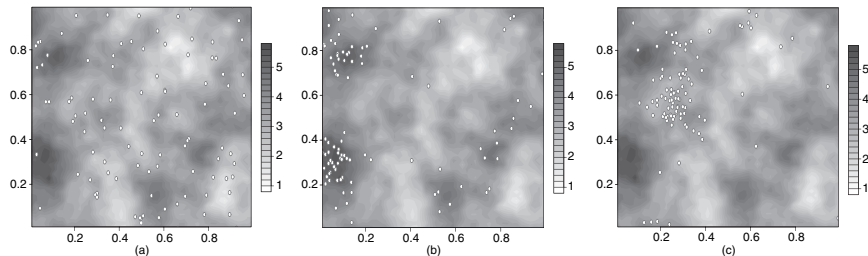


Figure : From Diggle et al. 2010

Variogram estimation tested under 500 simulations from three sampling designs:

- a Uniform
- b Preferential ($\beta = 2$)
- c Clustered

Classical Variogram Bias Under Preferential Sampling

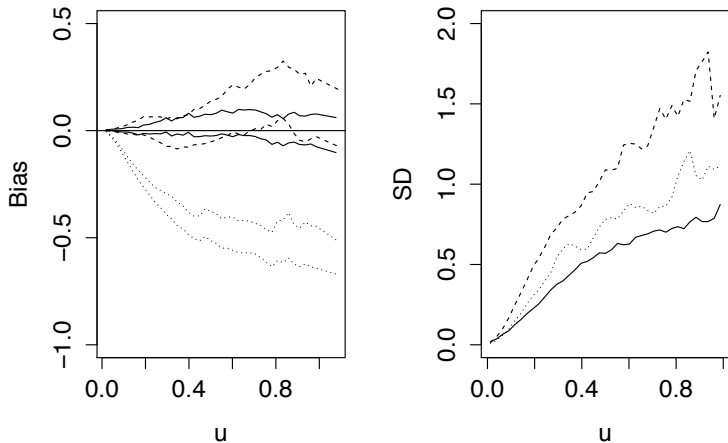


Figure : Variogram bias ± 2 standard errors and standard deviations for uniform (solid), clustered (dashed), and preferential (dotted) sampling schemes.

Classical Prediction Bias Under Preferential Sampling

Mod.	Param.	Confidence intervals		
		Uniform	Preferential	Clustered
1	Bias	(-0.029, 0.038)	(0.956, 1.123)	(-0.074, 0.064)
1	RMSE	(0.354, 0.410)	(1.318, 1.501)	(0.717, 0.851)
2	Bias	(-0.040, 0.030)	(-0.265, -0.195)	(-0.040, 0.032)
2	RMSE	(0.375, 0.425)	(0.434, 0.491)	(0.382, 0.432)

Table : Classical predictions using 95% Confidence intervals for the given parameters under the given models and sampling schemes

Models:

1. $(\mu = 4, \sigma^2 = 1.5, \phi = .15, \kappa = 1, \beta = 2)$
2. $(\mu = 1.51, \sigma^2 = .14, \phi = .31, \kappa = .5, \beta = -2.20, \tau^2 = .059)$

Preferential Model Likelihood

Make gridded approximation of $S = \{S_0, S_1\}$ on lattice $X^* = \{x_1^*, \dots, x_N^*\}$.

- ▶ S_0 are data
- ▶ S_1 are the values at other grid points

$$\begin{aligned} L(\vec{\theta}) &= \int \pi(Y|X, S) \pi(X|S) \pi(S) dS \\ &= \dots \\ &= E_{S|Y} \left[\pi(X|S) \frac{\pi(Y|S_0)}{\pi(S_0|Y)} \pi(S_0) \right] \\ &\approx m^{-1} \sum_{j=1}^m \pi(X|S_j) \frac{\pi(Y|S_{0j})}{\pi(S_{0j}|Y)} \pi(S_{0j}) \end{aligned}$$

where S_j is the j th conditional simulation of S conditioned on Y .

Preferential Model Likelihood

Define C as a $n \times N$ matrix with a single 1 in each row and all else 0 s.t. $X = CX^*$.

Steps for Monte Carlo Simulation:

1. Simulate $\vec{S} \sim \text{MVN}(\vec{0}, \Sigma)$ using Circulant Embedding (Wood and Chan, 1994)
2. Compute j th simulation of $\vec{S} | \vec{Y}$:

$$\vec{S}_j \equiv \vec{S} + \Sigma C' \Sigma_0^{-1} (\vec{Y} - \vec{\mu} + \vec{Z} - C\vec{S})$$

Where $Z_i \stackrel{iid}{\sim} \mathcal{N}(0, \tau^2)$

3. Calculate $m^{-1} \sum_{j=1}^m \pi(X | \vec{S}_j) \frac{\pi(\vec{Y} | \vec{S}_{0j})}{\pi(\vec{S}_{0j} | \vec{Y})} \pi(\vec{S}_{0j})$

Preferential Model Likelihood

$$\pi(X|\vec{S}_j) = \left(\prod_{i=1}^n \Lambda(x_i) \right) \left(\int \Lambda(x) \, dx \right)^{-n}$$

$$\vec{Y}|\vec{S}_{0j} \sim \text{MVN}\left(\vec{S}_{0j}, \tau^2 I\right)$$

$$\vec{S}_{0j}|\vec{Y} \sim \text{MVN}\left(\Sigma C' \Sigma_0^{-1}(\vec{Y} - \vec{\mu}), \Sigma - \Sigma C' \Sigma_0^{-1} C \Sigma\right)$$

$$\vec{S}_{0j} \sim \text{MVN}\left(\vec{0}, C \Sigma C'\right)$$

Goodness of Fit

Reduced second moment measure (or *K-function*) for defined model is given by:

$$K(s) = \pi s^2 + 2\pi \int_0^s (\exp \{ \beta^2 \sigma^2 \rho(u; \kappa, \phi) \} - 1) u \, du$$

s : distance

$\rho(u; \phi, \kappa)$: Matérn correlation function

K-functions commonly used in goodness of fit tests

Goodness of Fit: Monte Carlo Testing

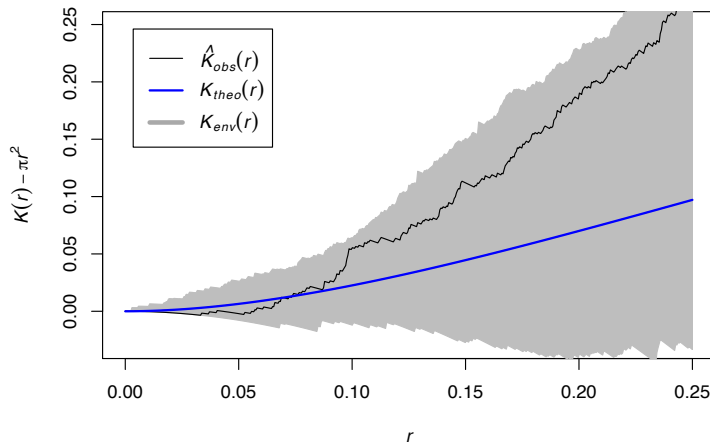
For any Monte Carlo test statistic, T , where higher T casts doubt on H_0 , assume:

- ▶ T_1 is from data
- ▶ T_2, \dots, T_n are simulated under H_0

Then our p -value is the rank of T_1 out of T_1, T_2, \dots, T_n (i.e. if $n = 100$ and T_1 is largest test statistic, $p = .01$).

Goodness of Fit: Monte Carlo Testing

Estimated, simulated, and theoretical K functions



$p = 0.07$

Problems with the Methodology

- ▶ No cross-validation performed (effectiveness of K -function goodness of fit tests unclear)
- ▶ Predictive distribution assumes non-preferentiality with plug-in parameters from preferential model
- ▶ Predictive distribution has unreasonable certainty in locations far from data
- ▶ Joint non-preferential model gives parameters similar to preferential model parameters:
 - ▶ My non-preferential model:
 $(\hat{\mu}_{97} = 1.551, \hat{\mu}_{00} = 0.727, \hat{\sigma}^2 = 0.136, \hat{\phi} = 0.305, \hat{\tau}^2 = 0.052)$
 - ▶ Their preferential model:
 $(\hat{\mu}_{97} = 1.515, \hat{\mu}_{00} = 0.762, \hat{\sigma}^2 = 0.138, \hat{\phi} = 0.313, \hat{\tau}^2 = 0.059)$

Conclusions

- ▶ For preferential simulations, variograms estimated naively were biased
- ▶ Uniform sampling performed best, then clustered, then preferential
- ▶ Proposed class of models is flexible and values for β can be tested directly with likelihood ratio test
- ▶ LGCP isn't necessarily the best fit for the log-lead data
- ▶ LGCP model gives tractable Monte Carlo likelihood
- ▶ LGCP model has easy goodness of fit tests

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